


<b>Search Notes</b> 	<b>Application/Control No.</b> 10594549	<b>Applicant(s)/Patent Under Reexamination</b> OHNO ET AL.
	<b>Examiner</b> Sharidan Carrillo	<b>Art Unit</b> 1792

SEARCHED			
Class	Subclass	Date	Examiner
134	18, 21, 25.1, 25.4, 26, 30, 31, 32, 33, 34, 36, 37, 42, 902	1/28/2010	bsc
34	60, 222, 443, 487, 488	1/29/2010	bsc

SEARCH NOTES		
Search Notes	Date	Examiner
East-uspat, epo, jpo, ibmtdb, pgpub, derwent. Consult with Jiping Lu, class 034.	1/28/2010	bsc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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